



PATENT  
81674-271623

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

J. HALBERT et al.

Serial No: 09/664,910

Filed: September 18, 2000

For: MEMORY MODULE AND MEMORY  
COMPONENT BUILT-IN SELF TEST

Art Unit: 2133  
Examiner: D.B. GANDHI

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Hon. Commissioner for Patents  
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October 8, 2003

Date of Deposit

Roger R. Wise

Name

*Roger R. Wise*

Signature

10/8/2003

Date

**REQUEST FOR CONTINUED EXAMINATION (RCE)  
AND PRELIMINARY AMENDMENT**

Hon. Commissioner for Patents  
P. O. Box 1450

**RECEIVED**

OCT 20 2003

**Technology Center 2100**

Dear Sir:

In response to the Final Office Action dated July 8, 2003 in connection with the  
above-identified application, Applicants respectfully submit a Request for Continued  
Examination (RCE) of the above-referenced application and a Preliminary Amendment.

Please consider the following amendments and remarks prior to examination of the  
above-identified RCE application.

**IN THE CLAIMS:**

Please amend claims 1, 9, 16, and 24, and add new claims 54-64 as follows:

1. (Currently Amended) A memory component with built-in self test,

comprising:

10/15/2003 HVUONG1 00000020 09664910

02 FC:1201  
03 FC:1202

172.00 OP  
198.00 OP

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